	FORM PTO-1449	Atty Docket 25582A	Serial No. 10/692,678
	INFORMATION DISCLOSURE CITATION	Applicant BABAYOFF et al.	
		Filing Date 10/27/03	Group Art Unit 3732




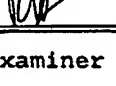
U.S. PATENT DOCUMENTS


Examiner Initial		Document Number	Issue Date	Name	Class	Sub-Class	Filing Date
	AA						
	AB						
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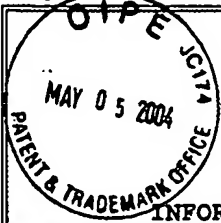
		Document Number	Date	Country	Class	Sub-Class	Translation
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
	AO						

OTHER (Including Author, Title, Date, Pertinent Pages, etc.)

	AP	Mörmann, W.H. et al. "THE FUNDAMENTAL INVENTIVE PRINCIPLES OF CEREC CAD / CIM AND OTHER CAD/ CAM METHODS", pp.81,82,88,93.
	AQ	Preston, J.D. et al. "CAD/CAM in Dentistry", AO, vol.89 pp.71-77, 1996.
	AR	Bertin, "Sensors", p. 17
	AS	Keyence, "How does the LT differ from conventional sensors?" p.2-3.

Examiner 	Date Considered 3/31/05
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FORM PTO-1449

INFORMATION DISCLOSURE CITATION

Atty Docket
25582ASerial No.
10/692,678Applicant
BABAYOFF et al.Filing Date
10/27/03Group Art Unit
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U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	Issue Date	Name	Class	Sub-Class	Filing Date
<i>[initials]</i>	AA	5,372,502	12/13/94	Massen et al.	—	—	11/07/91
<i>[initials]</i>	AB	4,575,805	03/11/86	Moermann et al.	—	—	08/23/84
<i>[initials]</i>	AC	5,737,084	04/07/98	Ishihara	—	—	09/26/96
<i>[initials]</i>	AD	5,381,236	01/10/95	Morgan	—	—	02/06/92
<i>[initials]</i>	AE	6,263,234	07/17/01	Engelhardt et al.	—	—	09/30/97
<i>[initials]</i>	AF	5,671,056	09/23/97	Sato	—	—	05/09/96
<i>[initials]</i>	AG	4,443,706	04/17/84	DiMatteo et al.	—	—	02/04/83
<i>[initials]</i>	AH	4,585,349	04/29/86	Gross et al.	—	—	09/12/84
<i>[initials]</i>	AI	5,239,178	08/24/93	Derndinger et al.	—	—	11/08/91
<i>[initials]</i>	AJ	5,338,198	08/16/94	Wu et al.	—	—	11/22/93
<i>[initials]</i>	AK	5,386,292	01/31/95	Massen et al.	—	—	04/27/93
<i>[initials]</i>	AL	5,801,880	09/01/98	Matsuda et al.	—	—	09/21/95

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		Document Number	Date	Country	Class	Sub-Class	Translation
<i>[initials]</i>	AM	0278882	17.08.88	EP	—	—	No
<i>[initials]</i>	AN	0679864A1	02.11.95	EP	—	—	N/A
<i>[initials]</i>	AO	2321517A	29.07.98	GB	—	—	N/A
<i>[initials]</i>	AP	19638758A1	19.03.98	DE	—	—	No
<i>[initials]</i>	AQ	2144537A	06.03.85	GB	—	—	N/A
<i>[initials]</i>	AR	19650391A1	10.06.98	DE	—	—	No
<i>[initials]</i>	AS	19640495A1	09.04.98	DE	—	—	No
<i>[initials]</i>	AT	97/37264A	09.10.97	WO	—	—	Abstract

OTHER (Including Author, Title, Date, Pertinent Pages, etc.)

<i>[initials]</i>	AU		
<i>[initials]</i>	AV		
<i>[initials]</i>	AW		

Examiner

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Date Considered

03/31/05

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